TOSHIBA

Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit	
Collector-emitter voltage	V_{CEO}	50	V	
Output withstand voltage	V _{CE} (SUS)	50	V	
Output current	lout	500	mA	
Input voltage	V _{IN}	-0.5~30	V	
Clamp diode reverse voltage	V _R	50	V	
Clamp diode forward current	l _F	500	mA	
Power dissipation	P _D (Note 4)	0.78	W	
Saturated thermal resistance	R _{th (j-a)} (Note 4)	160	°C/W	
Saturated thermal resistance	R _{th (j-c)} (Note 5)	25	C/VV	
Operating temperature	T _{opr}	-40~85	°C	
Storage temperature	T _{stg}	−55~150	°C	

Note 4: $114.3 \times 76.2 \times 1.6$ mm glass epoxy film substrate Cu heat dissipation pattern 100 mm²

Note 5: When an infinite heat sink is mounted.

Recommended Operating Condition ($Ta = -40 \sim 85$ °C)

Characteristics		Symbol	Test Condition	Min	Тур.	Max	Unit
Output withstand voltage	ge	V _{CEO}	_	0	_	50	V
Output current		lout	Ta = 60°C, T _j = 105°C	_	_	220	mA
Input voltage		V _{IN}	_	0	_	24	V
Input voltage	Output ON	V _{IN (ON)}	I _{OUT} = 400 mA, h _{FE} = 800	2.8	_	24	V
	Output OFF	V _{IN (OFF)}	_	0	_	0.7	v
Clamp diode reverse voltage		V_{R}	_	_	_	50	V
Clamp diode forward current		I _F	_	_	_	350	mA

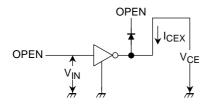
Electrical Characteristics (Ta = 25°C)

Characteristics		Symbol	Test Circuit	Test Condition		Min	Тур.	Max	Unit
Output leakage current		I _{CEX}	1	V _{CE} = 50 V, V _{IN} = OPEN		_	_	10	μΑ
Output saturation voltage		V _{CE (sat)}	2	$I_{OUT}=300$ mA, $I_{IN}=500$ μA		_	1.1	1.3	V
				$I_{OUT}=200$ mA, $I_{IN}=350$ μA		_	1.0	1.2	
DC current amplification ratio		h _{FE}	2	V _{CE} = 2.0 V, I _{OUT} = 350 mA		1000	_	_	
Input current	Output ON	I _{IN} (ON)	3	$V_{IN} = 2.4 \text{ V}, I_{OUT} = 350 \text{ mA}$		_	0.4	0.7	mA
Input voltage	Output ON	V _{IN} (ON)	4	1 VCE - 2 V,	I _{OUT} = 350 mA	_	_	2.6	V
	Output ON				I _{OUT} = 200 mA	_	_	2.2	7 V
Clamp diode leakage current		I _R	5	V _R = 50 V			_	10	μΑ
Clamp diode forward voltage V _F 6 I _F = 350 mA			1.6	2.0	V				
Turn-on delay		t _{ON}	7	$V_{OUT} = 50 \text{ V}, R_L = 125 \Omega,$			0.02	_	
Turn-off delay		t _{OFF}	C _L = 15 pF		5 pF		1.0	_	μ\$

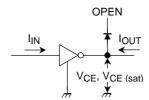
2

Test Circuit

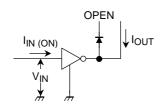
1. I_{CEX}



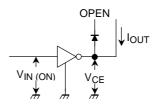
2. V_{CE (sat)}, h_{FE}



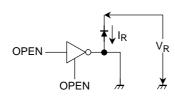
3. I_{IN} (ON)



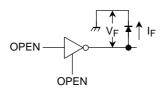
4. V_{IN (ON)}



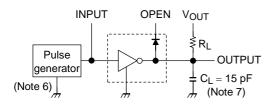
5. I_R



6. V_F



7. ton, toff



Output impedance 50 Ω , $t_f \le 5$ ns, $t_f \le 10$ ns

5 V **INPUT** 90% 90% 50% 10% 50 μs toN toff V_{OH} 90% OUTPUT 10% V_{OL}

Note 7: C_L includes probe and jig capacitance.

Note 6: Pulse width 50 µs, Duty cycle 10%

Caution on Application

- 1. The device does not include protectors such as an overcurrent protector and an overvoltage protector. Applying excessive current or voltage may damage the device.
 - Thus, design with great care to prevent excessive current or voltage from being applied to the device. The device may also be damaged by short-circuits between outputs and power supply/ground. Take care when designing output, VCC and GND line.

3

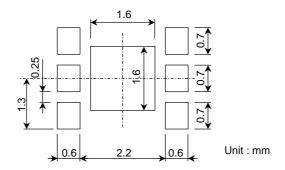
2. Be sure to mount the device in the correct orientation. Make sure that the positive and negative power supply pins are connected the right way round. Otherwise, the absolute maximum current and power dissipation ratings may be exceeded and the device may break down or undergo performance degradation, causing it to catch fire or explode, and resulting in injury.

Package Dimensions

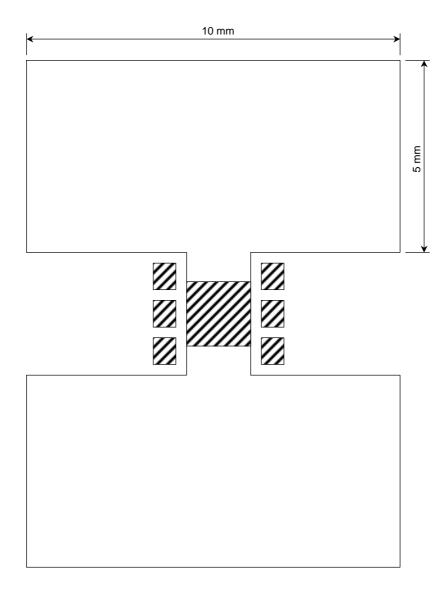
<mark>- </mark>	

Weight: 0.017 g (typ.)

Preliminary land pattern



Preliminary PCB trace dimension



RESTRICTIONS ON PRODUCT USE

000707EBA

- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
 In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc..
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.). These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in this document shall be made at the customer's own risk.
- The products described in this document are subject to the foreign exchange and foreign trade laws.
- The information contained herein is presented only as a guide for the applications of our products. No responsibility is assumed by TOSHIBA CORPORATION for any infringements of intellectual property or other rights of the third parties which may result from its use. No license is granted by implication or otherwise under any intellectual property or other rights of TOSHIBA CORPORATION or others.
- The information contained herein is subject to change without notice.